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FDP2D3N10C / FDPF2D3N10C

N-Channel Shielded Gate PowerTrench[®] MOSFET 100 V, 222 A, 2.3 m Ω

Features

- Max $r_{DS(on)} = 2.3 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 100 \text{ A}$
- Extremely Low Reverse Recovery Charge, Qrr

TO-220

- 100% UIL Tested
- RoHS Compliant

General Description

This N-Channel MV MOSFET is produced using ON Semiconductor's advanced PowerTrench® process that incorporates Shielded Gate technology. This process has been optimized to minimize on-state resistance and yet maintain superior switching performance with best in class soft body diode.

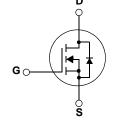
Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- Motor drives and Uninterruptible Power Supplies
- Micro Solar Inverter

TO-220F







MOSFET Maximum Ratings $T_C = 25$ °C unless otherwise noted.

Symbol	Parameter		Rati	Units			
Symbol	Faranteter			FDP2D3N10C	FDPF2D3N10C	Ullits	
V_{DS}	Drain to Source Voltage			100	100	V	
V_{GS}	Gate to Source Voltage			±20	±20	V	
	Drain Current -Continuous	T _C = 25°C	(Note 3)	222*	222*		
I_D	-Continuous	T _C = 100°C	(Note 3)	157*	157*	Α	
	-Pulsed		(Note 1)	888	888		
E _{AS}	Single Pulse Avalanche Energy		(Note 2)	1176		mJ	
В	Power Dissipation	T _C = 25°C		214	45	W	
P_{D}	Power Dissipation	T _A = 25°C		2.4	2.4	VV	
T_J , T_{STG}	Operating and Storage Junction Te	emperature Range		-55 to	+175	°C	

^{*} Drain current limited by maximum junction temperature. Package limitation current is 120A.

Thermal Characteristics

Symbol	Parameter	FDP2D3N10C	FDPF2D3N10C	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.7	3.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	62.5	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Packing Method	Quantity
FDP2D3N10C	FDP2D3N10C	TO-220	Tube	50 units
FDPF2D3N10C	FDPF2D3N10C	TO-220F	Tube	50 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		70		mV/°C
	Zero Gate Voltage Drain Current	V _{DS} = 80 V, V _{GS} = 0 V			1	μΑ
DSS	Zero Gate voltage Drain Current	V _{DS} = 80 V, T _J = 150°C			500	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 700 \mu A$	2.0	3.0	4.0	V
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 100 \text{ A}$		2.1	2.3	mΩ
9 _{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 100 \text{ A}$		222		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz		7980	11180	pF
C _{oss}	Output Capacitance			4490	6290	pF
C _{rss}	Reverse Transfer Capacitance			40	75	pF
R_g	Gate Resistance		0.1	0.8	1.8	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		42	67	ns
t _r	Rise Time	V _{DD} = 50 V, I _D = 100 A,	35	56	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	74	118	ns
t _f	Fall Time		32	57	ns
Q_g	Total Gate Charge	$V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{DD} = 50 \text{ V},$	108	152	nC
Q_{gs}	Gate to Source Gate Charge	V _{DD} = 50 V,	36		nC
Q_{gd}	Gate to Drain "Miller" Charge	IB = 100 A	22		nC
Q _{oss}	Output Charge	V _{DD} = 50 V, V _{GS} = 0 V	297		nC

Drain-Source Diode Characteristic

IS	Maximum Continuous Drain to Source Diode Forward Current		-	-	222	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	888	Α
V_{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 100 A		0.9	1.3	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, V _{DD} = 50 V,		107	172	ns
Q _{rr}	Reverse Recovery Charge	$I_F = 100 \text{ A}, dI_F/dt = 100 \text{ A/}\mu\text{s}$		191	306	nC
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, V _{DD} = 50 V,		97	155	ns
Q _{rr}	Reverse Recovery Charge	$I_F = 100 \text{ A}, dI_F/dt = 300 \text{ A/}\mu\text{s}$		492	788	nC

Notes:

- 1. Pulsed Id please refer to Figure.11 and Figure.12 "Forward Bias Safe Operating Area" for more details.
- $2. \; E_{AS} \; \text{of} \; \; 1176 \; \text{mJ} \; \; \text{is based on starting T}_{J} = 25 \; ^{\circ}\text{C}, \; L = 3 \; \text{mH}, \; I_{AS} = 28 \; \text{A}, \; V_{DD} = 90 \; \text{V}, \; V_{GS} = 10 \; \text{V}. \; \; 100\% \; \text{test at L} = 0.1 \; \text{mH}, \; I_{AS} = 89 \; \text{A}. \; \; \text{M}_{AS} = 10 \; \text{M}_{$
- 3. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

Typical Characteristics $T_J = 25$ °C unless otherwise noted.

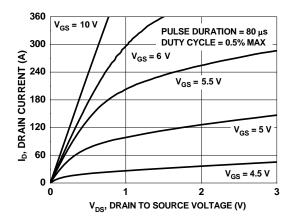


Figure 1. On-Region Characteristics

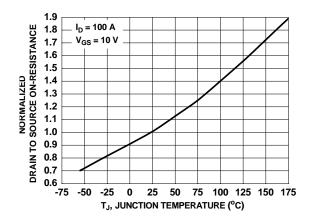


Figure 3. Normalized On-Resistance vs. Junction Temperature

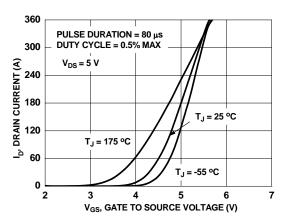


Figure 5. Transfer Characteristics

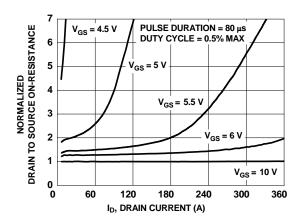


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

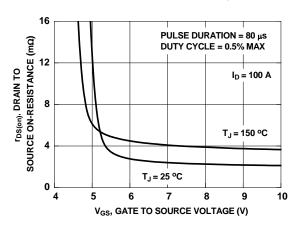


Figure 4. On-Resistance vs. Gate to Source Voltage

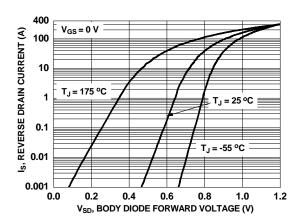


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

Typical Characteristics $T_J = 25 \, ^{\circ}\text{C}$ unless otherwise noted.

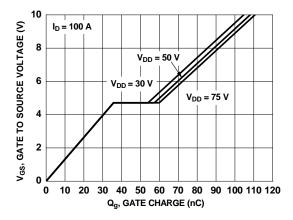


Figure 7. Gate Charge Characteristics

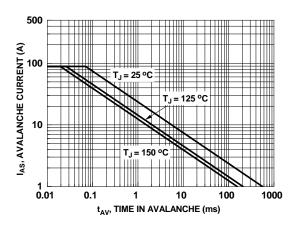


Figure 9. Unclamped Inductive Switching Capability

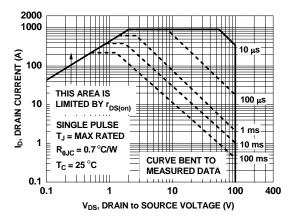


Figure 11. Forward Bias Safe Operating Area for FDP2D3N10C

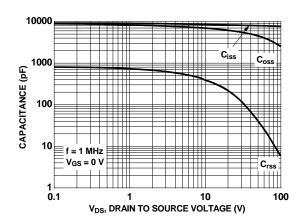


Figure 8. Capacitance vs. Drain to Source Voltage

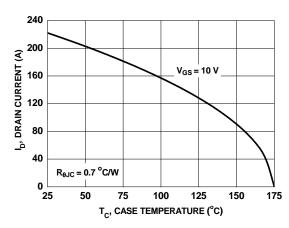


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

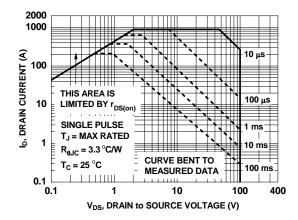
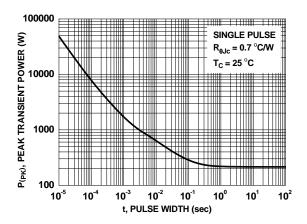


Figure 12. Forward Bias Safe Operating Area for FDPF2D3N10C

Typical Characteristics $T_J = 25$ °C unless otherwise noted.



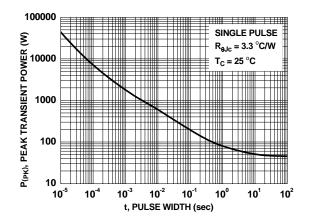


Figure 13. Single Pulse Maximum Power Dissipation for FDP2D3N10C

Figure 14. Single Pulse Maximum Power Dissipation for FDPF2D3N10C

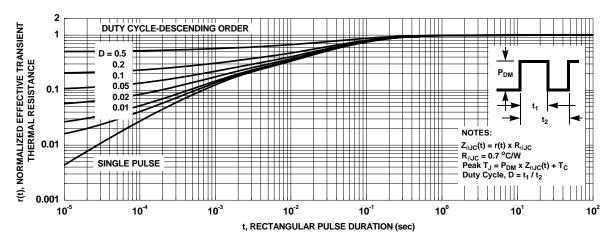


Figure 15. Junction-to-Case Transient Thermal Response Curve for FDP2D3N10C

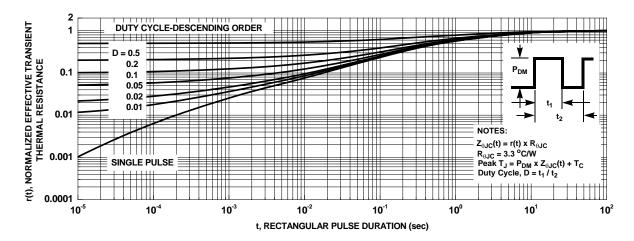
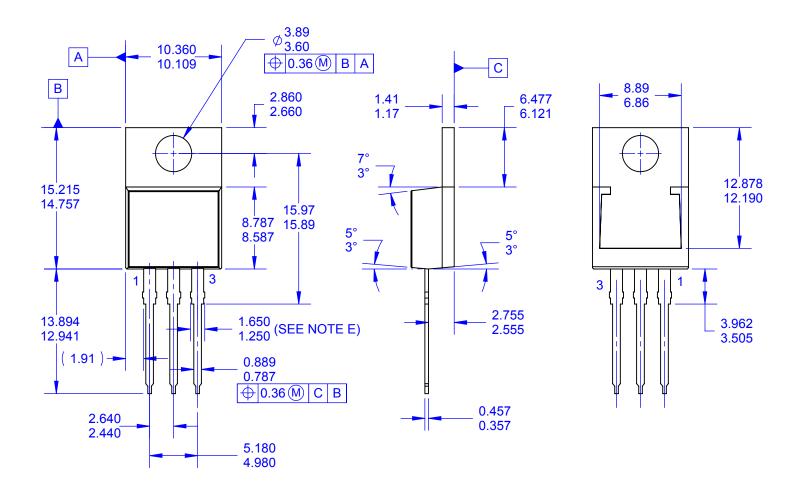
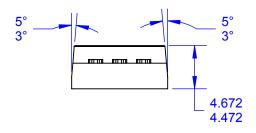


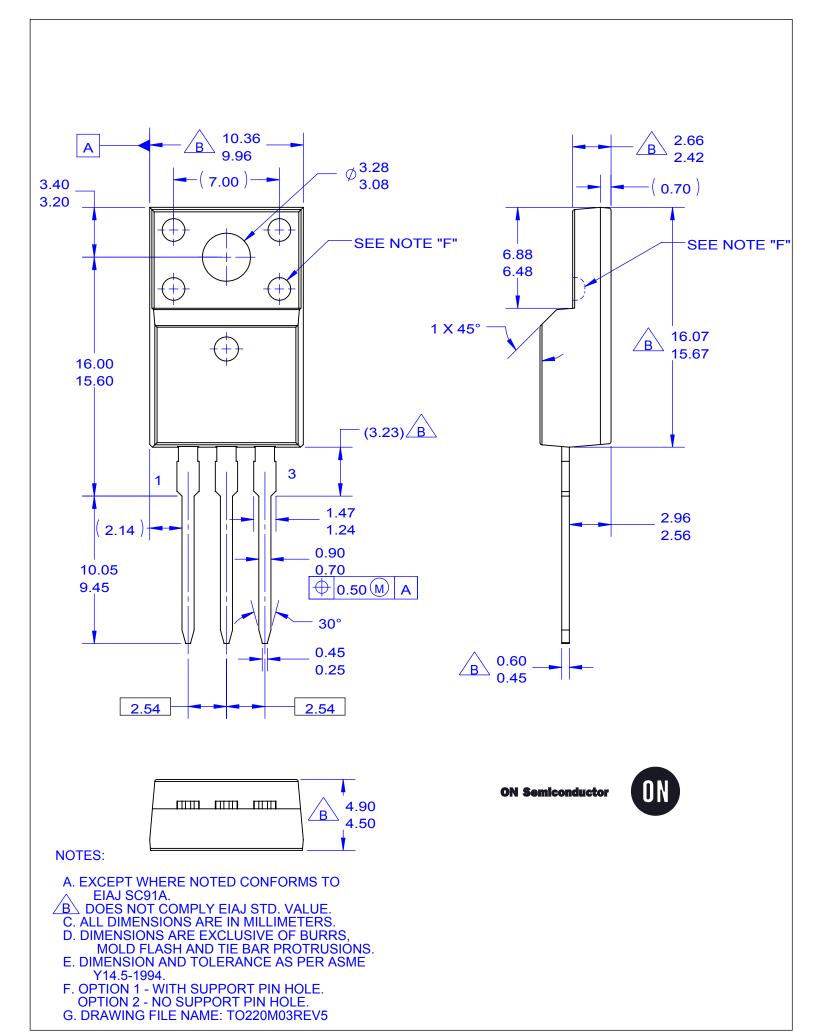
Figure 16. Junction-to-Case Transient Thermal Response Curve for FDPF2D3N10C





NOTES:

- A. PACKAGE REFERENCE: JEDEC TO220 **VARIATION AB**
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.
- D. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.
- E. MAX WIDTH FOR F102 DEVICE = 1.35mm. F. DRAWING FILE NAME: TO220T03REV4.
- G. FAIRCHILD SEMICONDUCTOR.



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